Search Notes



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Reexamination

Applicant(s)/Patent Under

OH, JEONG-HWAN

Examiner

Lavin, Christopher L

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
382	135,137-140	02/01/07	CLL

SEARCH NOTES

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East Search	02/01/07	CLL

INTERFERENCE SEARCH

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